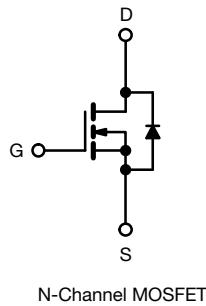
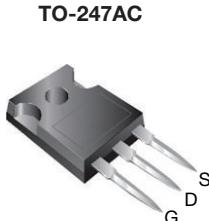


## E Series Power MOSFET

PRODUCT SUMMARY	
$V_{DS}$ (V) at $T_J$ max.	700
$R_{DS(on)}$ typ. ( $\Omega$ ) at 25 °C	$V_{GS} = 10$ V 0.090
$Q_g$ max. (nC)	173
$Q_{gs}$ (nC)	29
$Q_{gd}$ (nC)	49
Configuration	Single



### FEATURES

- Low figure-of-merit (FOM)  $R_{on} \times Q_g$
- Low input capacitance ( $C_{iss}$ )
- Reduced switching and conduction losses
- Ultra low gate charge ( $Q_g$ )
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see [www.vishay.com/doc?99912](http://www.vishay.com/doc?99912)



RoHS  
COMPLIANT  
HALOGEN  
FREE

### APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial
  - Welding
  - Induction heating
  - Motor drives
  - Battery chargers
  - Renewable energy
  - Solar (PV inverters)

### ORDERING INFORMATION

Package	TO-247AC
Lead (Pb)-free and Halogen-free	SiHG33N65E-GE3

### ABSOLUTE MAXIMUM RATINGS ( $T_C = 25$ °C, unless otherwise noted)

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	$V_{DS}$	650	V
Gate-Source Voltage	$V_{GS}$	$\pm 30$	
Continuous Drain Current ( $T_J = 150$ °C)	$V_{GS}$ at 10 V	32.4	A
		21	
Pulsed Drain Current <sup>a</sup>	$I_{DM}$	101	W/°C
Linear Derating Factor		2.5	
Single Pulse Avalanche Energy <sup>b</sup>	$E_{AS}$	596	mJ
Maximum Power Dissipation	$P_D$	313	W
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	-55 to +150	°C
Drain-Source Voltage Slope	$dV/dt$	70	V/ns
Reverse Diode $dV/dt$ <sup>d</sup>		16	
Soldering Recommendations (Peak temperature) <sup>c</sup>	for 10 s	300	°C

#### Notes

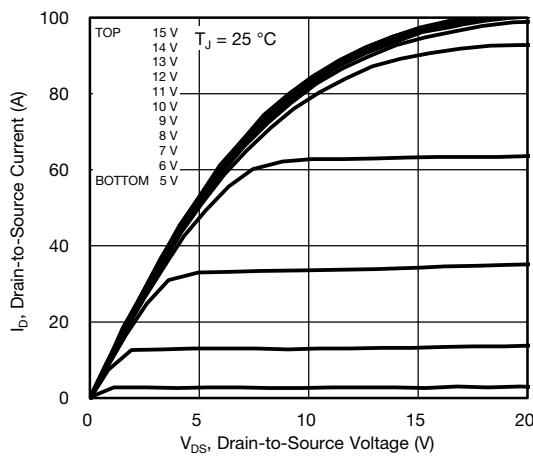
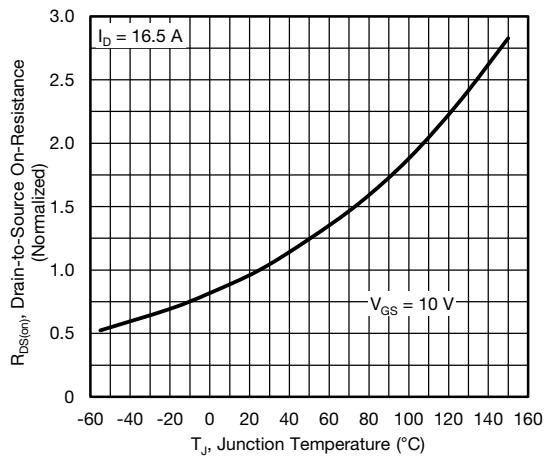
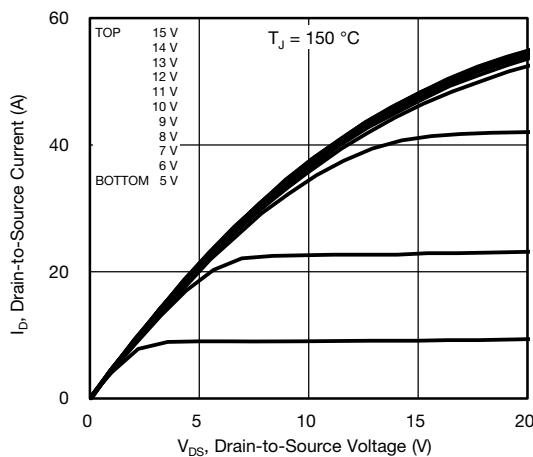
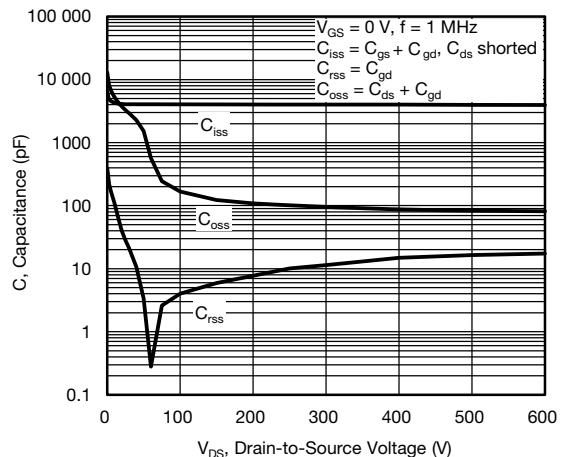
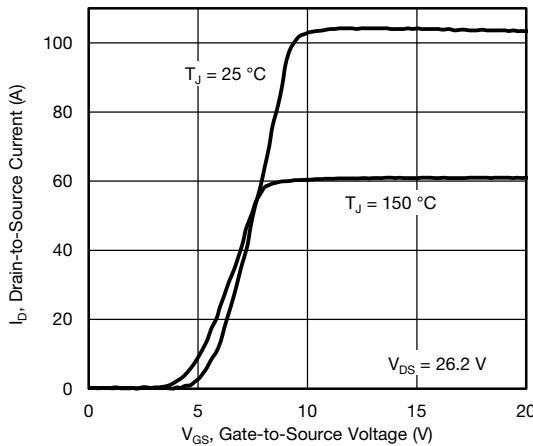
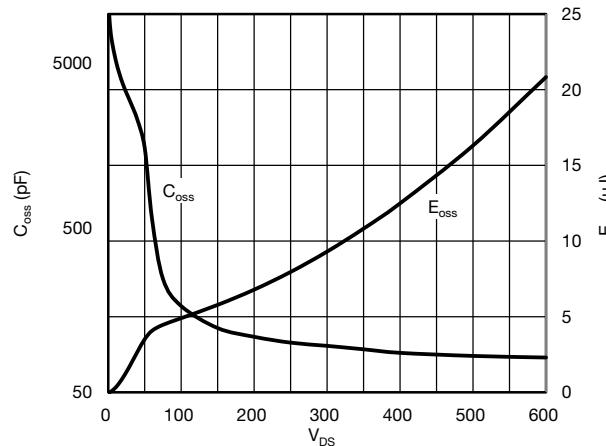
- Repetitive rating; pulse width limited by maximum junction temperature.
- $V_{DD} = 140$  V, starting  $T_J = 25$  °C,  $L = 28.2$  mH,  $R_g = 25$  Ω,  $I_{AS} = 6.5$  A.
- 1.6 mm from case.
- $I_{SD} \leq I_D$ ,  $dl/dt = 100$  A/μs, starting  $T_J = 25$  °C.

THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	-	40	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	0.4	°C/W

SPECIFICATIONS ( $T_J = 25$ °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
<b>Static</b>							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0$ V, $I_D = 250$ μA		650	-	-	V
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to 25 °C, $I_D = 1$ mA		-	0.84	-	V/°C
Gate-Source Threshold Voltage (N)	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 250$ μA		2.0	-	4.0	V
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 20$ V		-	-	± 100	nA
		$V_{GS} = \pm 30$ V		-	-	± 1	μA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 650$ V, $V_{GS} = 0$ V		-	-	1	
		$V_{DS} = 520$ V, $V_{GS} = 0$ V, $T_J = 125$ °C		-	-	10	μA
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10$ V	$I_D = 16.5$ A	-	0.090	0.105	Ω
Forward Transconductance <sup>a</sup>	$g_{fs}$	$V_{DS} = 30$ V, $I_D = 16.5$ A		-	11.5	-	S
<b>Dynamic</b>							
Input Capacitance	$C_{iss}$	$V_{GS} = 0$ V, $V_{DS} = 100$ V, $f = 1.0$ MHz		-	4040	-	pF
Output Capacitance	$C_{oss}$			-	123	-	
Reverse Transfer Capacitance	$C_{rss}$			-	6	-	
Effective Output Capacitance, Energy Related <sup>a</sup>	$C_{o(er)}$	$V_{DS} = 0$ V to 520 V, $V_{GS} = 0$ V		-	121	-	
Effective Output Capacitance, Time Related <sup>b</sup>	$C_{o(tr)}$			-	501	-	
Total Gate Charge	$Q_g$			-	115	173	nC
Gate-Source Charge	$Q_{gs}$	$V_{GS} = 10$ V	$I_D = 16.5$ A, $V_{DS} = 520$ V	-	29	-	
Gate-Drain Charge	$Q_{gd}$			-	49	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 520$ V, $I_D = 16.5$ A, $V_{GS} = 10$ V, $R_g = 9.1$ Ω		-	35	70	ns
Rise Time	$t_r$			-	67	100	
Turn-Off Delay Time	$t_{d(off)}$			-	103	155	
Fall Time	$t_f$			-	60	90	
Gate Input Resistance	$R_g$	$f = 1$ MHz, open drain		0.25	0.50	1.0	Ω
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	$I_S$	MOSFET symbol showing the integral reverse p - n junction diode		-	-	32.4	A
Pulsed Diode Forward Current	$I_{SM}$			-	-	101	
Diode Forward Voltage	$V_{SD}$	$T_J = 25$ °C, $I_S = 16.5$ A, $V_{GS} = 0$ V		-	-	1.2	V
Body Diode Reverse Recovery Time	$t_{rr}$	$T_J = 25$ °C, $I_F = I_S = 16.5$ A, $dl/dt = 100$ A/μs, $V_R = 25$ V		-	605	-	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$			-	11	-	μC
Reverse Recovery Current	$I_{RRM}$			-	28	-	A

**Notes**

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .  
b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

**Fig. 1 - Typical Output Characteristics,  $T_C = 25 \text{ }^\circ\text{C}$** 

**Fig. 4 - Normalized On-Resistance vs. Temperature**

**Fig. 2 - Typical Output Characteristics,  $T_C = 150 \text{ }^\circ\text{C}$** 

**Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage**

**Fig. 3 - Typical Transfer Characteristics**

**Fig. 6 -  $C_{oss}$  and  $E_{oss}$  vs.  $V_{DS}$**

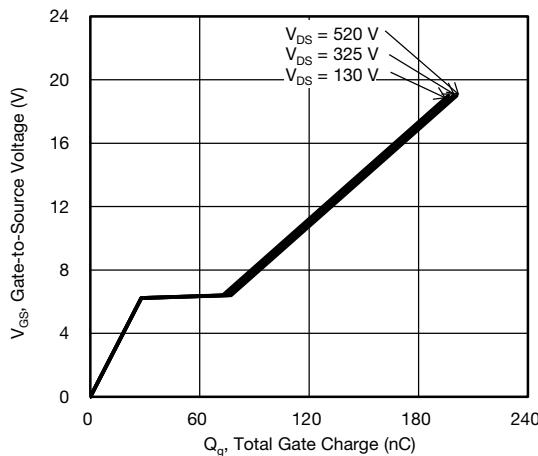


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

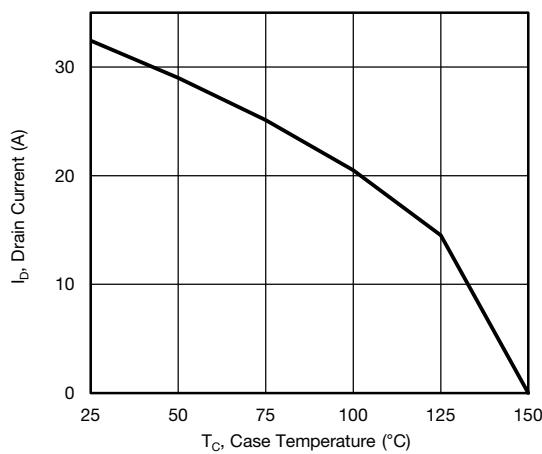


Fig. 10 - Maximum Drain Current vs. Case Temperature

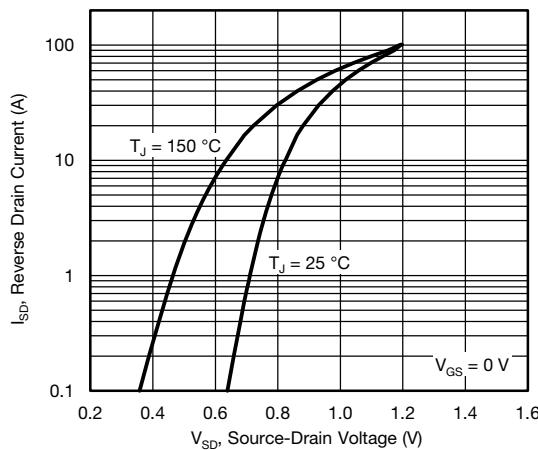


Fig. 8 - Typical Source-Drain Diode Forward Voltage

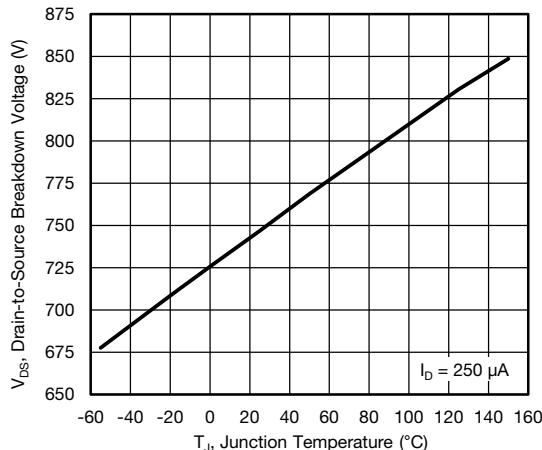


Fig. 11 - Temperature vs. Drain-to-Source Voltage

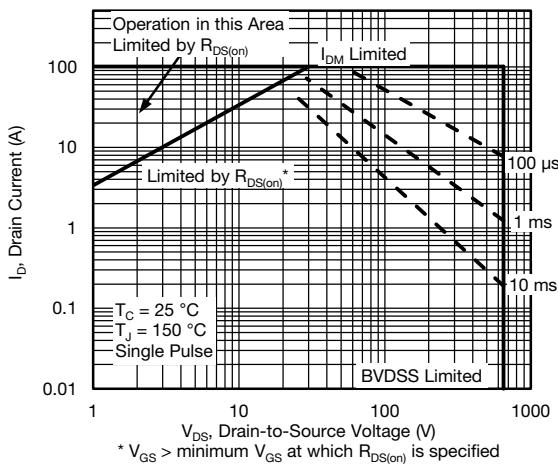
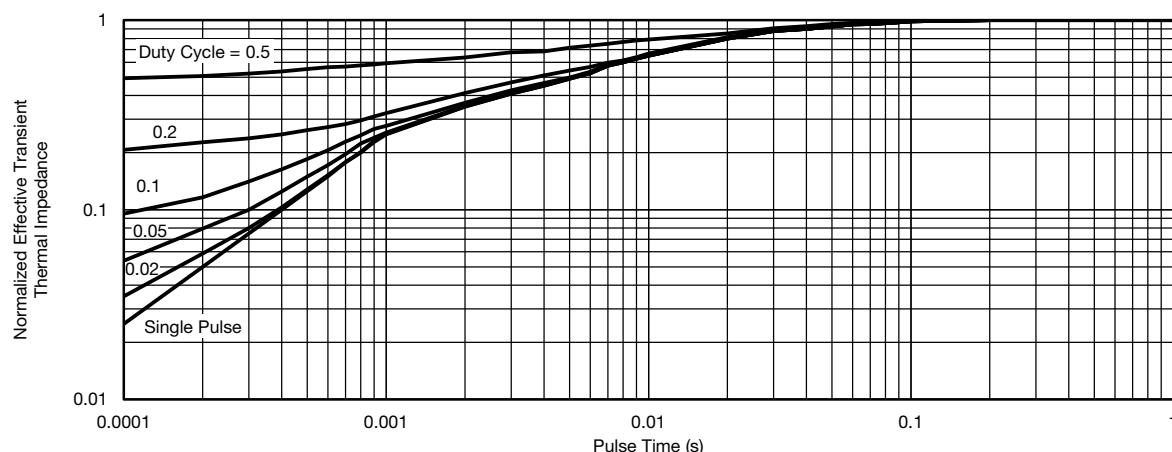
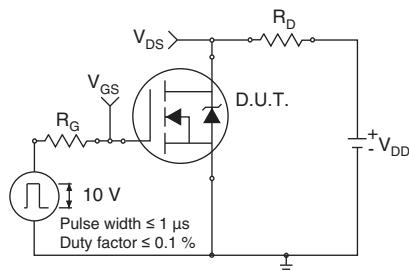


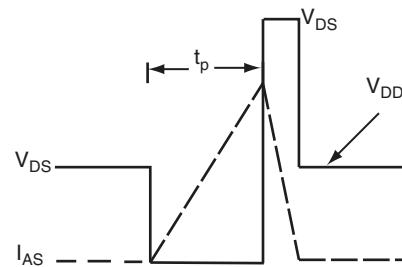
Fig. 9 - Maximum Safe Operating Area



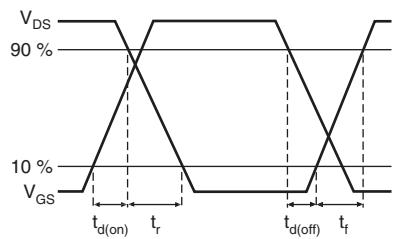
**Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case**



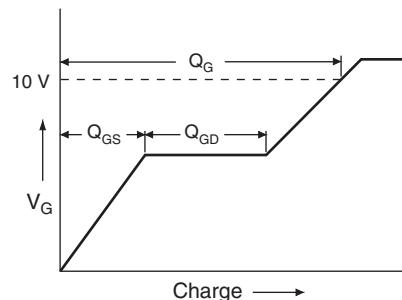
**Fig. 13 - Switching Time Test Circuit**



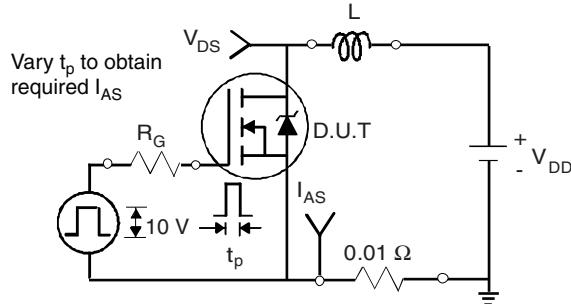
**Fig. 16 - Unclamped Inductive Waveforms**



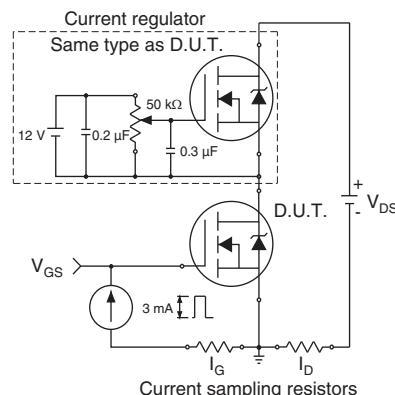
**Fig. 14 - Switching Time Waveforms**



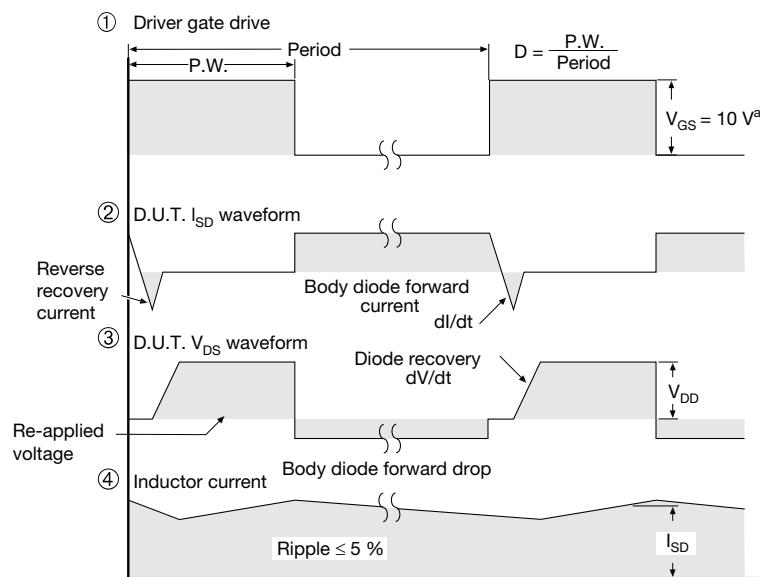
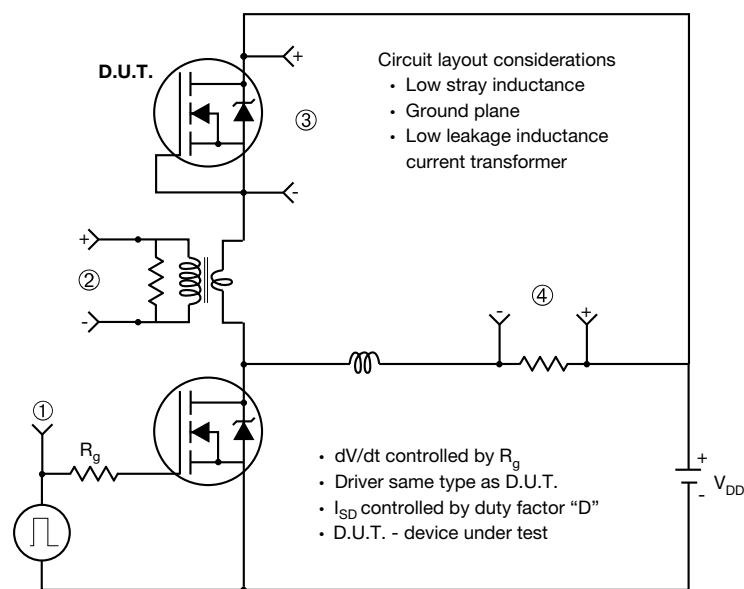
**Fig. 17 - Basic Gate Charge Waveform**



**Fig. 15 - Unclamped Inductive Test Circuit**



**Fig. 18 - Gate Charge Test Circuit**

**Peak Diode Recovery dV/dt Test Circuit**

**Fig. 19 - For N-Channel**

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